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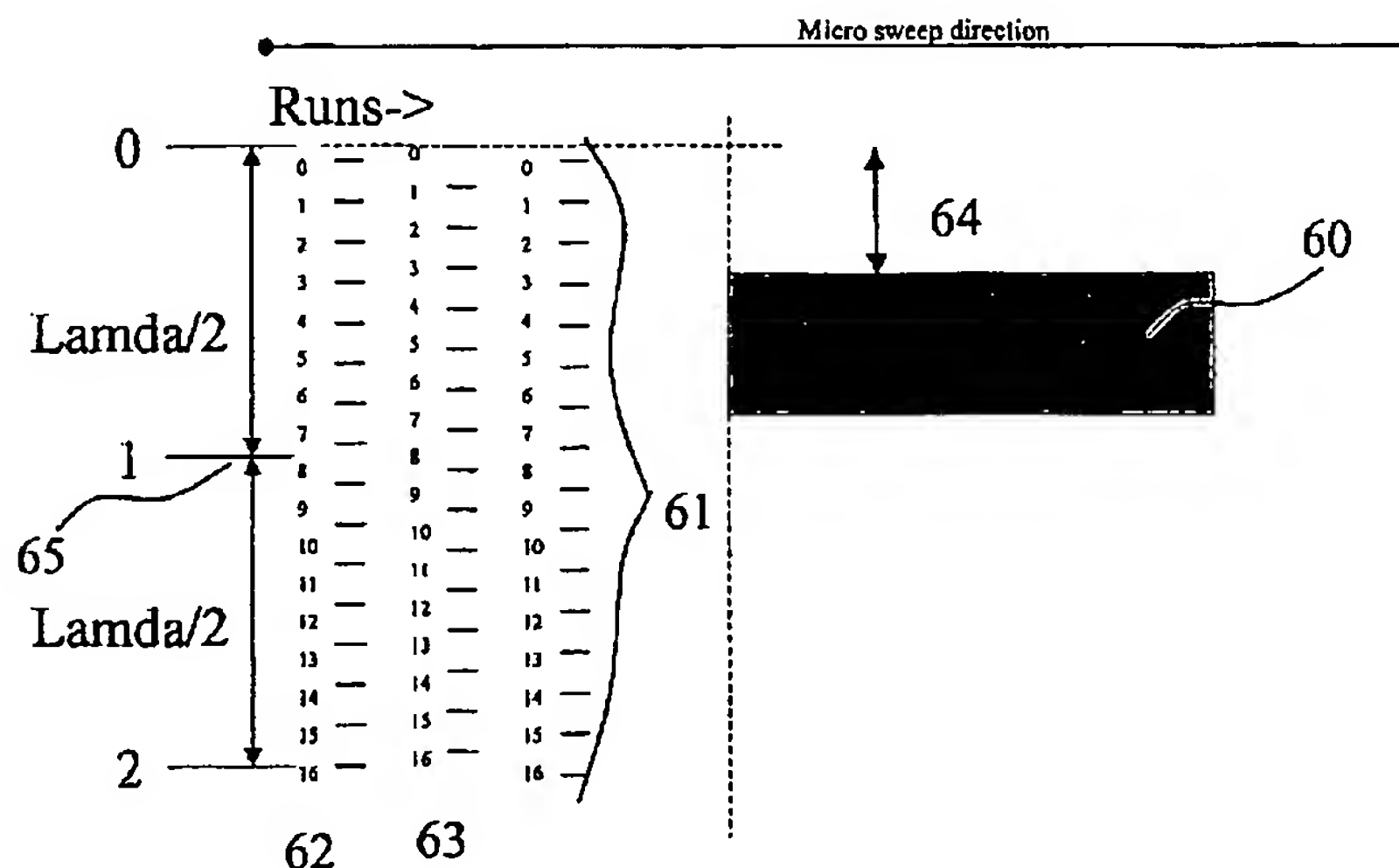
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(54) Title: A METHOD FOR MEASURING THE POSITION OF A MARK IN A DEFLECTOR SYSTEM



(57) Abstract: The present invention relates to a method for determining the coordinates of an arbitrarily shaped pattern in a deflec-  
tor system. The method basically comprises the steps of: moving the pattern in a first direction (X), calculating the position of the  
edge of the pattern by counting the number of micro sweeps, performed in a perpendicular direction (Y), until the edge is detected,  
and determining the coordinates by relating the number of counted micro sweeps to the speed of the movement of the pattern. The  
invention also relates to software implementing the method.



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